

**P-CHANNEL MOS FIELD EFFECT TRANSISTOR
FOR SWITCHING**

DESCRIPTION

The μPA1817 is a switching device which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power management of notebook computers and so on.

FEATURES

- 2.5 V drive available
- Low on-state resistance
 $R_{DS(on)1} = 12 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.5 \text{ V, } I_D = -6.0 \text{ A)}$
 $R_{DS(on)2} = 12.5 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.0 \text{ V, } I_D = -6.0 \text{ A)}$
 $R_{DS(on)3} = 19.2 \text{ m}\Omega \text{ MAX. (} V_{GS} = -2.5 \text{ V, } I_D = -6.0 \text{ A)}$
- Built-in G-S protection diode against ESD

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|---------------|--------------|
| μPA1817GR-9JG | Power TSSOP8 |

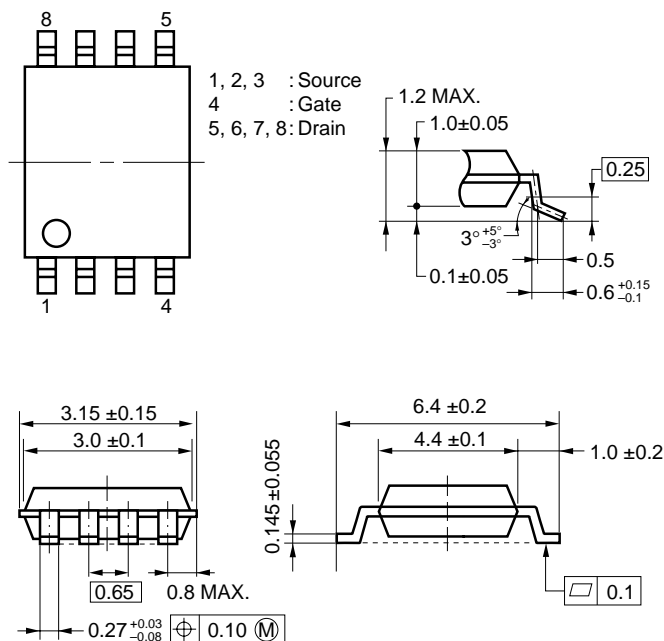
ABSOLUTE MAXIMUM RATINGS (T_A = 25°C)

| | | | |
|---|-----------------------|-------------|----|
| Drain to Source Voltage (V _{GS} = 0 V) | V _{DSS} | -20 | V |
| Gate to Source Voltage (V _{DS} = 0 V) | V _{GSS} | ±12 | V |
| Drain Current (DC) (T _A = 25°C) | I _{D(DC)} | ±12 | A |
| Drain Current (pulse) ^{Note1} | I _{D(pulse)} | ±48 | A |
| Total Power Dissipation ^{Note2} | P _T | 2.0 | W |
| Channel Temperature | T _{ch} | 150 | °C |
| Storage Temperature | T _{stg} | -55 to +150 | °C |

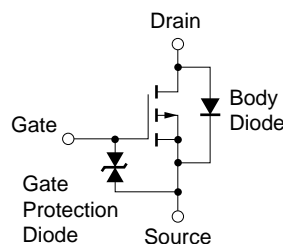
- Notes 1.** PW ≤ 10 μs, Duty Cycle ≤ 1%
2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT

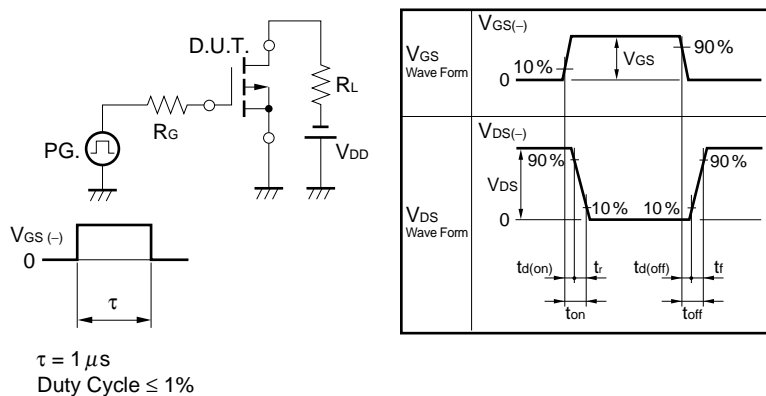


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 Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

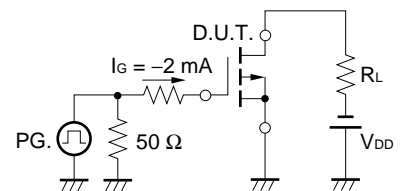
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = -20 V, V _{GS} = 0 V | | | -1.0 | μA |
| Gate Leakage Current | I _{GSS} | V _{GS} = ±12 V, V _{DS} = 0 V | | | ±10 | μA |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = -10 V, I _D = -1.0 mA | -0.5 | -1.1 | -1.5 | V |
| Forward Transfer Admittance | y _{fs} | V _{DS} = -10 V, I _D = -6.0 A | 15 | 30 | | S |
| Drain to Source On-state Resistance | R _{DS(on)1} | V _{GS} = -4.5 V, I _D = -6.0 A | | 9.6 | 12 | mΩ |
| | R _{DS(on)2} | V _{GS} = -4.0 V, I _D = -6.0 A | | 10 | 12.5 | mΩ |
| | R _{DS(on)3} | V _{GS} = -2.5 V, I _D = -6.0 A | | 14.5 | 19.2 | mΩ |
| Input Capacitance | C _{iss} | V _{DS} = -10 V | | 3100 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V | | 730 | | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1.0 MHz | | 450 | | pF |
| Turn-on Delay Time | t _{d(on)} | V _{DD} = -10 V, I _D = -6.0 A | | 29 | | ns |
| Rise Time | t _r | V _{GS} = -4.0 V | | 235 | | ns |
| Turn-off Delay Time | t _{d(off)} | R _G = 10 Ω | | 170 | | ns |
| Fall Time | t _f | | | 230 | | ns |
| Total Gate Charge | Q _G | V _{DD} = -16 V | | 27 | | nC |
| Gate to Source Charge | Q _{GS} | V _{GS} = -4.0 V | | 5.6 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = -12 A | | 12 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | I _F = 12 A, V _{GS} = 0 V | | 0.82 | | V |
| Reverse Recovery Time | t _{rr} | I _F = 12 A, V _{GS} = 0 V | | 70 | | ns |
| Reverse Recovery Charge | Q _{rr} | di/dt = 100 A/μs | | 52 | | nC |

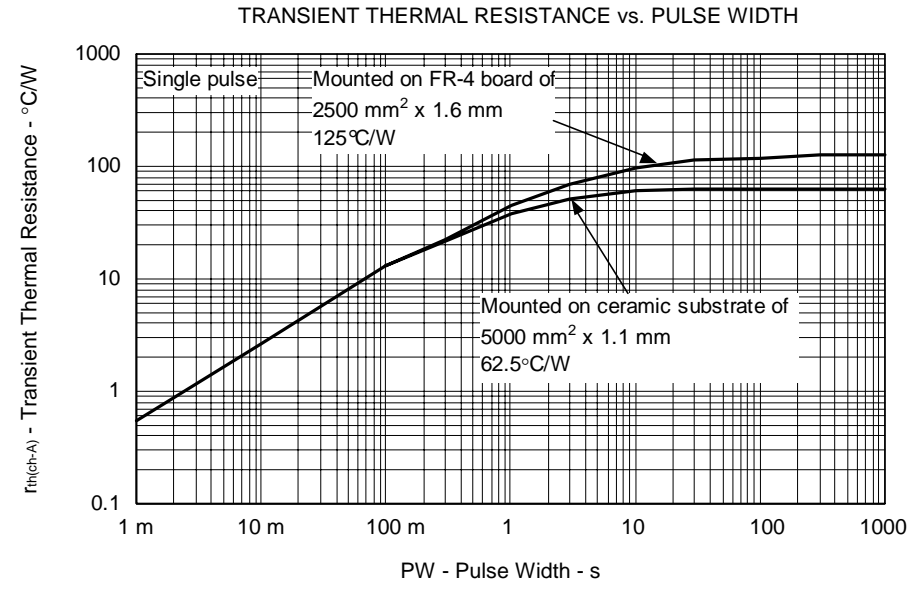
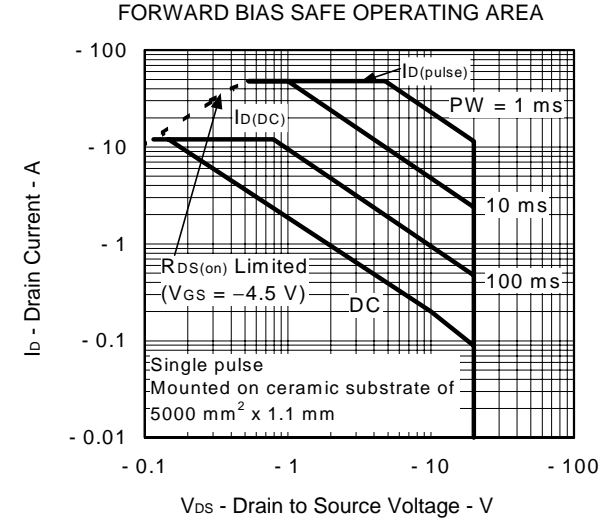
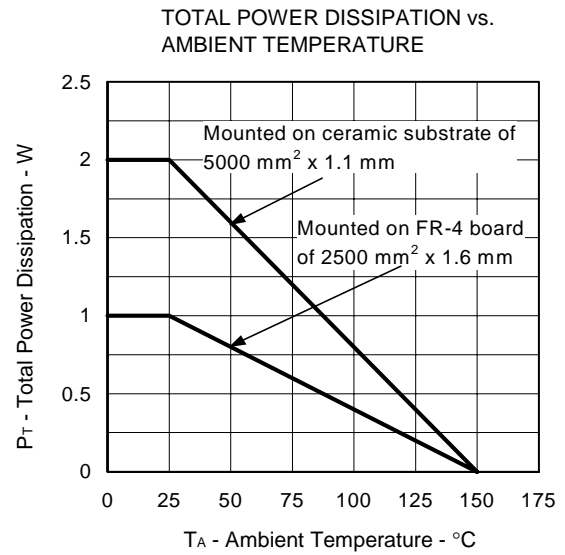
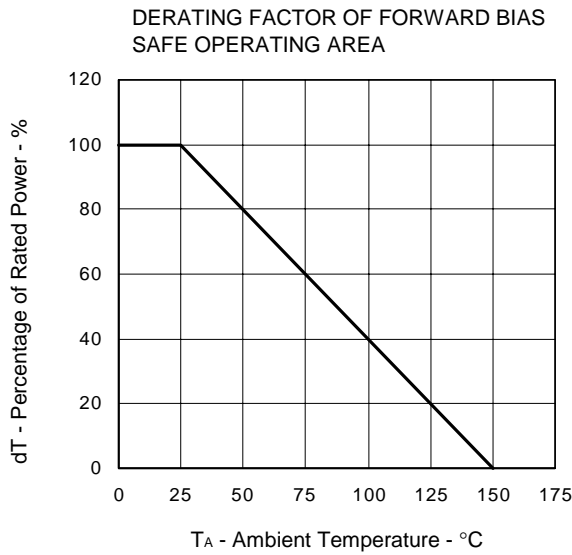
TEST CIRCUIT 1 SWITCHING TIME



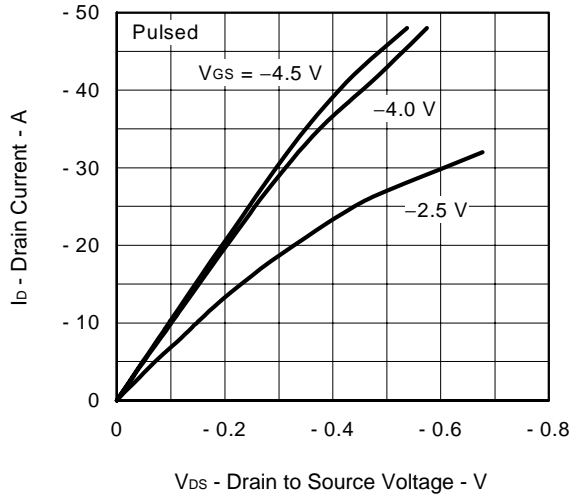
TEST CIRCUIT 2 GATE CHARGE



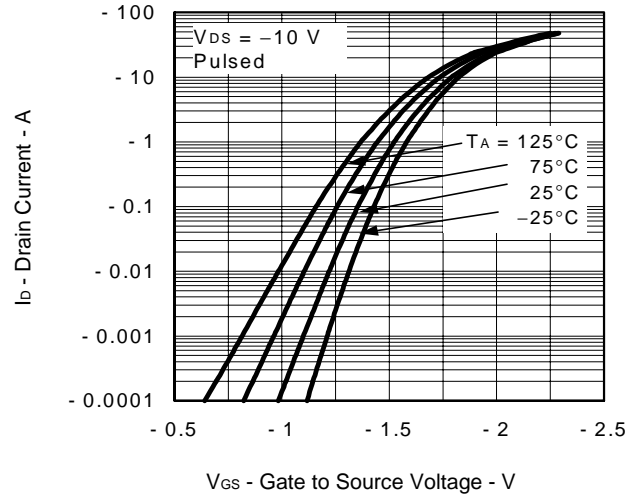
TYPICAL CHARACTERISTICS (T_A = 25°C)



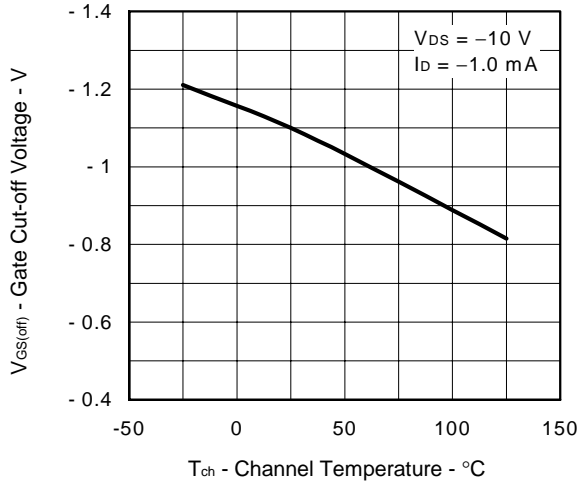
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



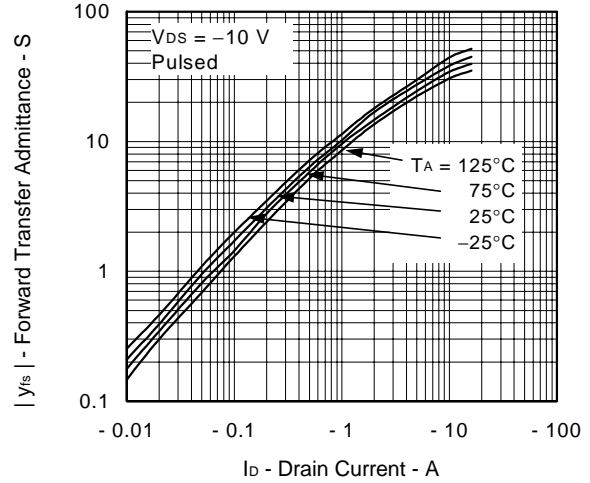
FORWARD TRANSFER CHARACTERISTICS



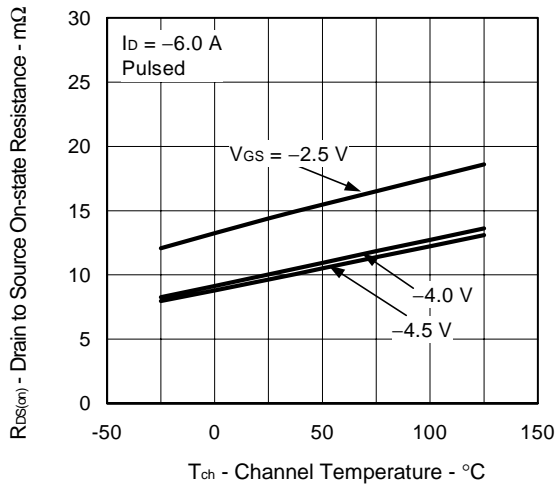
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



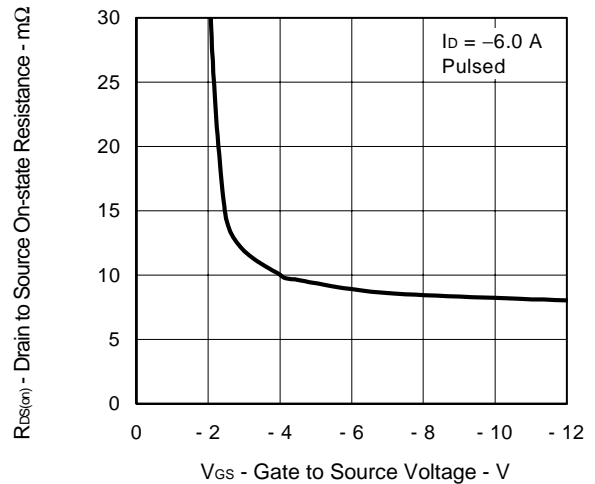
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



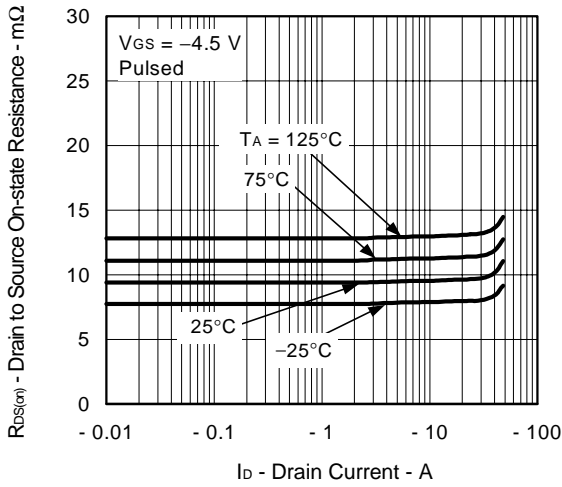
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



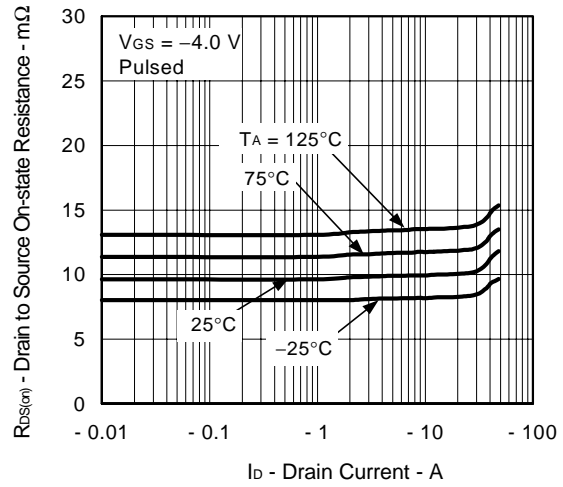
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



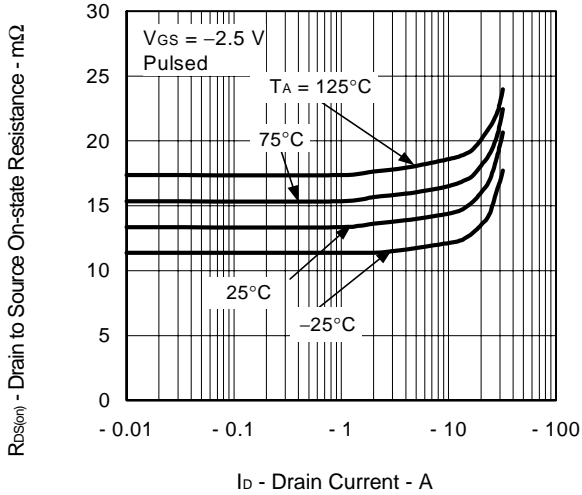
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



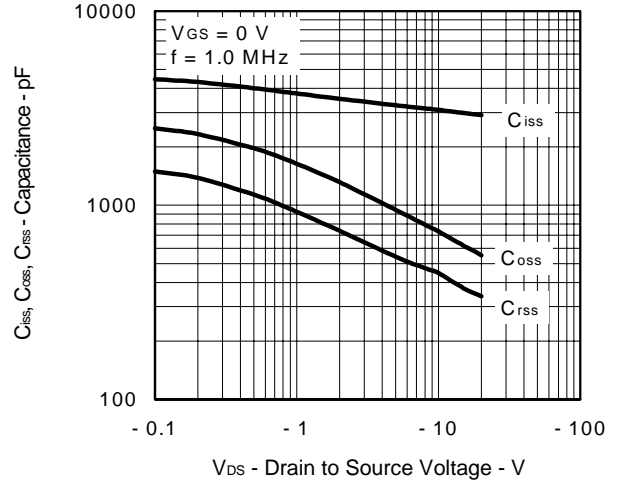
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



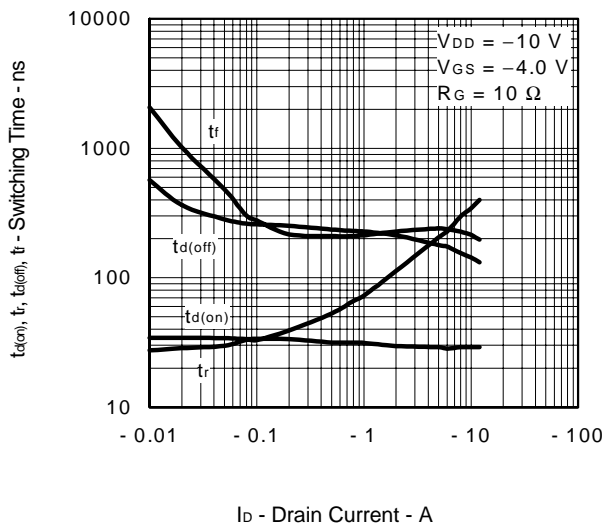
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



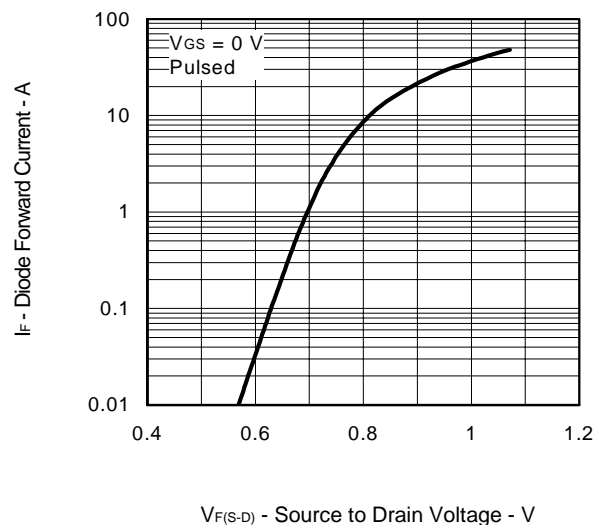
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



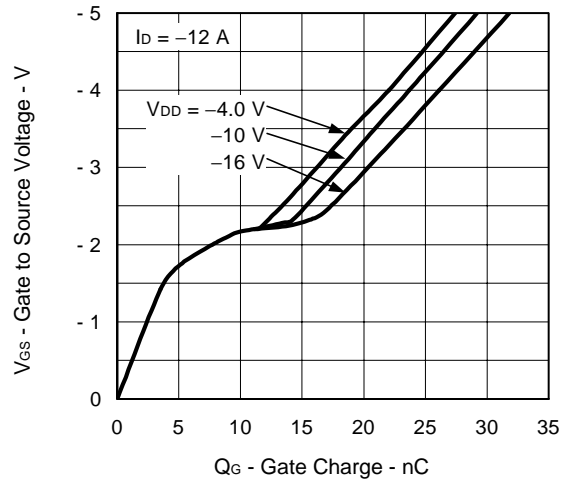
SWITCHING CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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